


<b>Search Notes</b>  	<b>Application/Control No.</b>  10583909	<b>Applicant(s)/Patent Under Reexamination</b>  LEE, MARTIN ADRIAN
	<b>Examiner</b>  Stefan Kruer	<b>Art Unit</b>  3654

SEARCHED			
Class	Subclass	Date	Examiner
187	272, 275	03/16/2008	SHK
91	110, 156, 165R, 168		
F15B	15/14		
B66B	9/04		

SEARCH NOTES			
Search Notes		Date	Examiner
PLUS		03/16/2008	SHK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner